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| Notice of References Cited | Application/Control No. 09/603,615 | Applicant(s)/Patent Under Reexamination LEE, HEE-JIN | |
| | Examiner Timothy Lee | Art Unit 2662 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-6,590,865 B1 | 07-2003 | Ibaraki et al. | 370/230 |
| | B | US-5,706,439 | 01-1998 | Parker, Tony E. | 370/234 |
| | C | US-5,815,492 A | 09-1998 | Berthaud et al. | 370/234 |
| | D | US-6,360,287 B1 | 03-2002 | Kawamura, Harumi | 710/61 |
| | E | US-6,101,613 A | 08-2000 | Gamey et al. | 713/600 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
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NON-PATENT DOCUMENTS

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|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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Notice of References CitedApplication/Control No.
09/603,615Applicant(s)/Patent Under
Reexamination
LEE, HEE-JINExaminer
Timothy LeeArt Unit
2662

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------|----------------|
| | A | US-6,324,178 B1 | 11-2001 | Lo et al. | 370/392 |
| | B | US-6,351,465 B1 | 02-2002 | Han, Yih-Wu | 370/395.43 |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

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| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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